Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/510,013	SHIN ET AL.		
Examiner	Art Unit		
Tai Duong	2871		

SEARCHED				
Class	Subclass	Date	Examiner	
349	38	9/4/2006	TD	
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	167			
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257	59		F	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM TDB) see search history printout	9/4/2006	TD		